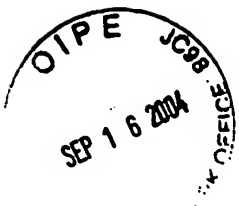


IFW



PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Serial No.: 10/718,554

Confirmation No.: 1824

In re Application of:

Tetsuya SATOU et al.

Group Art Unit: 1774

Filed: November 24, 2003

Examiner: Marie Rose Yamnitzky

For: THIN FILM EL DEVICE

TRANSMITTAL OF CORRECTED PTO-1449

Commissioner for Patents
P. O. Box 1450
Alexandria, Virginia 22313-1450

Sir:

The PTO-1449 accompanying the Information Disclosure Statement filed August 6, 2004 contained errors in identifying the second and third references. A corrected PTO-1449 is enclosed herewith. The oversight is regretted.

Respectfully submitted,

PARKHURST & WENDEL, L.L.P.

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Date

CAW/ch

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SERIAL NO.
10/718,554APPLICANT
Tetsuya SATOU et al.FILING DATE
November 24, 2003GROUP
1774

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	6,541,129 B1	4/1/03	Kawamura et al.	428	690	
	2003/0143430 A1	7/31/03	Kawamura et al.	428	690	
	2003/0207153 A1	11/6/03	Senoo et al.	428	690	
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	5,792,557	8/11/98	Nakaya et al.	428	411.1	

FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION NO YES	
	6-240245	8/30/94	Japan (w/Abstract)			X	
	2000-309566	11/7/00	Japan (w/corresponding US patents)			X	
	2000-16973	1/18/00	Japan (w/corresponding US patent)			X	
	7-188130	7/25/95	Japan (w/Abstract)			X	
	10-251633	9/22/98	Japan (w/corresponding US patents)			X	
	8-48656	2/20/96	Japan (w/corresponding US patent)			X	

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER

DATE CONSIDERED

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.